Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/621,322	LAI ET AL.	
Examiner	Art Unit	
Phu Vu	2871	

SEARCHED					
Class	Subclass	Date	Examiner		
349	65	9 /8/or	P.L		

INI	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Text Sec-Ln (us Patj P6 Pab)	7/6/08	P.L.		